

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10599546	BAE ET AL.
	Examiner Chen, Catheryne	Art Unit 1655

SEARCHED

Class	Subclass	Date	Examiner
none	none	11/05/07	CC

SEARCH NOTES

Search Notes	Date	Examiner
INVENTOR NAME, USPT, JPAB, EPAB, DWPI, MEDLINE, EMBASE, BIOSIS, CAPLUS, REGISTRY	11/05/07	CC

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner